## Microstructured LCMO: Electroresistance effects

Christianne: groupmeeting 01-10-07 (APL **91** 062101 (2007))

### Manganites



- Manganites have a metal-insulator transition at T<sub>c</sub>
- Inhomogeneous state → phase separation → percolative conductance leads to nonlinear IV-curves.

# LCMO



- 4pt. IV curves, size:  $t = 8 \text{ nm}, w = 5 \mu \text{m}$
- asymmetry, nonlinearity and hysteresis!
- partly probing the bridge but current leakage

# STO

- 4pt. IV curves 30 sec etched (350 V; 10 mA) STO, size: 2.6 x 1.5 mm<sup>2</sup>
- conducting STO, resistance comparable to the bridge







Kan et al. Nat. Mater. 4 (2005):

- sheet resistance Ar-etched STO (300 V)
- 1 min (light blue line) comparable to our sheet resistance

Solution: short O<sub>2</sub> plasma etch restores insulating state of STO

## LCMO (treated)



• 4pt. IV curves, size: t = 8 nm,  $w = 5 \mu \text{m}$ 

- linear + symmetrical IV curves for T = 10 300 K
- no Electroresistance for J : 2.5  $10^5 \text{ A/m}^2$  -1.5  $10^9 \text{ A/m}^2$

## Electroresistance



Sun et al. APL 86 (2005):

- 2pt. IV curves, size: t = 120 nm, w = 200 μm
- current processing  $\rightarrow$  <u>J = 1.6 10<sup>9</sup> A/m<sup>2</sup></u>
- Electroresistance + contact resistance

Zhao et al. APL 86 (2005):

- 4pt. R vs. T size: t = 100 nm, w = 50 μm
- strongly decreasing R as function of I
  → J = 2 10<sup>5</sup> A/m<sup>2</sup> 1.2 10<sup>9</sup> A/m<sup>2</sup>
- Electroresistance ( $T_p$  no shift) + heating ( $T_p$  shift to lower T)
- others report  $T_p$  shift to higher T like MR



Our samples: very homogeneous even on micrometer scale ?!



- IV curves 2 pt. vs. 4 pt. at 10 K
- dV/dI (inset) shows clear nonlinearity of the 2pt. IV due to large contact resistance

- VI curve (2 pt.) at 50 K shows resistance switching, Joule heating?
- estimation indicates that Joule heating is significant



## Conclusions

- No electroresistance is observed in our (treated) LCMO microbridges.
- Peculiarities in IVs are caused by:
  - conducting STO
  - large contact resistance
  - Joule heating

### **Recent results**

bridge: 1 x 20  $\mu$ m<sup>2</sup>; t = 10 nm Au contacts

bridge  $\perp$  steps; measured in PPMS during cooling



T<sub>p1</sub> ~ 190 K; T<sub>p2</sub> ~ 145 K

### **Recent results**

bridge: 1 x 20  $\mu$ m<sup>2</sup>; t = 10 nm Au contacts

bridge  $\perp$  steps; R vs. T from IV curve; I = 0.6  $\mu$ A



Τ<sub>p</sub> ~ 170 K

Zero current feature 110 K to 140 K

### 4 x 4 μm rms roughness: 0.24 nm

L477 1.0 deg STO 1 x 1 µm rms roughness: 0.25 nm rm

300 x 300 nm rms roughness: 0.187 nm









Number of events

#### Flat STO for STM L478

### 15 x 15 µm

rms roughness: 2.01 nm



Clean IPA, ethanol, acetone ultrasound + cotton tip 5 x 5 μm rms roughness: 2.38 nm





Topography [nm]





Topography [nm]

#### Flat STO for STM L478 CLEAN!!

### 15 x 15 µm

#### rms roughness: 0.238 nm

1.5 x 1.5 μm rms roughness: 0.196 nm







0.6

